

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10733264	HOSHUYAMA, HIDEO
	Examiner	Art Unit
	Tsai, Tsung-Yin	2609

SEARCHED

Class	Subclass	Date	Examiner
382	254 with text	10/29/2010	TYT
	Review search above	4/4/2011	TYT

SEARCH NOTES

Search Notes	Date	Examiner
IEEE	3/12/2010	TYT
IDS and Given english NPL	3/12/2010	TYT
Inventor Search on eDan	3/12/2010	TYT
Google Patent	3/12/2010	TYT
Google Scholar with inventor and keyword search	3/12/2010	TYT
US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	3/12/2010	TYT
Classification Search	3/12/2010	TYT
forward and backward citation	3/12/2010	TYT
Review and Update search above	10/29/2010	TYT
Andrew Johns (Primary 2624): Consult: using new and better reference with RCE. Result: Always provide new or even better reference when possible especially with new non-final office action.	10/29/2010	TYT
Review search above	4/4/2011	TYT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner